

Application/Control No	Applicant(s)/Patent u Reexamination	ınder
09/844,673	THEKKATH, RADH	IKA
Examiner	Art Unit	
J. Derek Rutten	2192	

SEARCHED				
Class	Subclass	Date	Examiner	
	1			
	-			

	INTERFERENCE SEARCHED				
Subclass	Date	Examiner			
ch notes	9/28/2006	JDR			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	9/22/2006	JDR		
717/128 text search only See search history printout	9/22/2006	JDR		
Tuan Dam (consulted re. allowable subject matter)	9/22/2006	JDR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	9/28/2006	JDR		
717/124,127,128; 712/220,227; 714/25,45 Text search only See search history printout	9/28/2006	JDR		
ACM - portal.acm.org IEEE - ieeexplore.ieee.org See search history printout	9/28/2006	JDR		